

## Performance Specification

Model	Marking	V <sub>max</sub> (Vdc)	I <sub>max</sub> (A)	I <sub>hold</sub> @25°C (A)	I <sub>trip</sub> @25°C (A)	P <sub>d</sub> Typ. (W)	Maximum Time To Trip		Resistance	
							Current (A)	Time (Sec)	R <sub>i min</sub> (Ω)	R <sub>1max</sub> (Ω)
SMD0805P050TF/12	5	12.0	30	0.50	1.00	0.5	8.0	0.10	0.100	0.850

V<sub>max</sub> = Maximum operating voltage device can withstand without damage at rated current (I<sub>max</sub>).

I<sub>max</sub> = Maximum fault current device can withstand without damage at rated voltage (V<sub>max</sub>).

I<sub>hold</sub> = Hold Current. Maximum current device will not trip in 25°C still air.

I<sub>trip</sub> = Trip Current. Minimum current at which the device will always trip in 25°C still air.

P<sub>d</sub> = Power dissipation when device is in the tripped state in 25°C still air environment at rated voltage.

R<sub>i min</sub>/max = Minimum/Maximum device resistance prior to tripping at 25°C.



R<sub>1max</sub> = Maximum device resistance is measured one hour post reflow.

CAUTION : Operation beyond the specified ratings may result in damage and possible arcing and flame.

## Environmental Specifications

Test	Conditions	Resistance change
Passive aging	+85°C, 1000 hrs.	±5% typical
Humidity aging	+85°C, 85% R.H. , 168 hours	±5% typical
Thermal shock	+85°C to -40°C, 20 times	±33% typical
Resistance to solvent	MIL-STD-202, Method 215	No change
Vibration	MIL-STD-202, Method 201	No change
Ambient operating conditions : - 40 °C to +85 °C		
Maximum surface temperature of the device in the tripped state is 125 °C		

## Agency Approval and Environmental Compliance

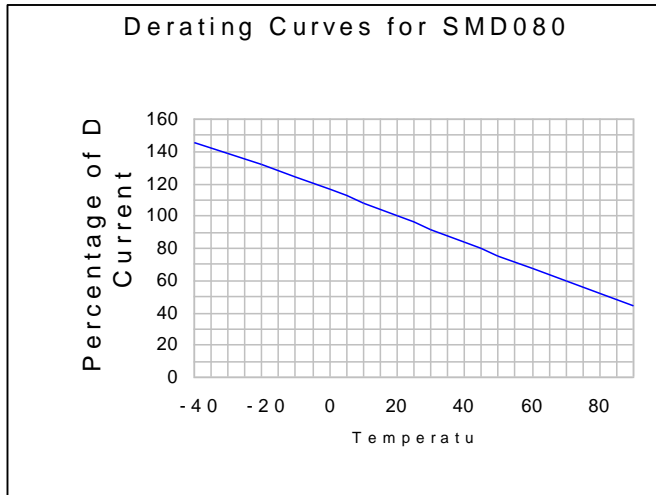
Agency	File Number	Regulation	Standard
UL	E486890		2011/65/EU
TUV	pending		EN14582

## Thermal Derating Chart

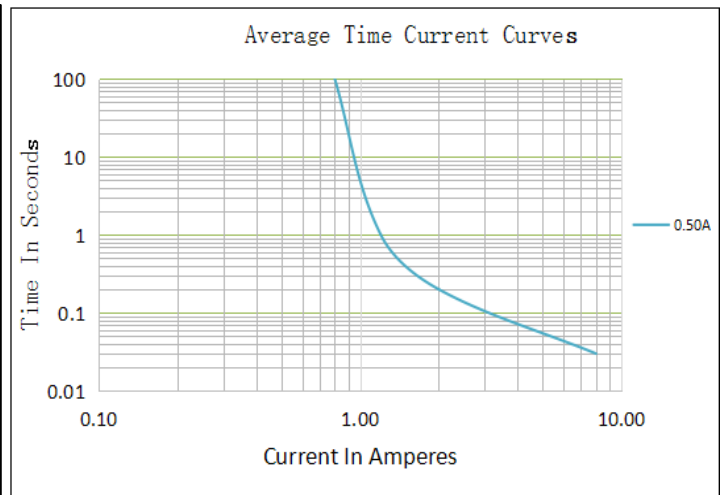
Recommended Hold Current(A) at Ambient Temperature(°C)

Model	Ambient Operation Temperature								
	-40°C	-20°C	0°C	25°C	40°C	50°C	60°C	70°C	85°C
SMD0805P050TF/12	0.68	0.62	0.55	0.50	0.40	0.37	0.33	0.29	0.23

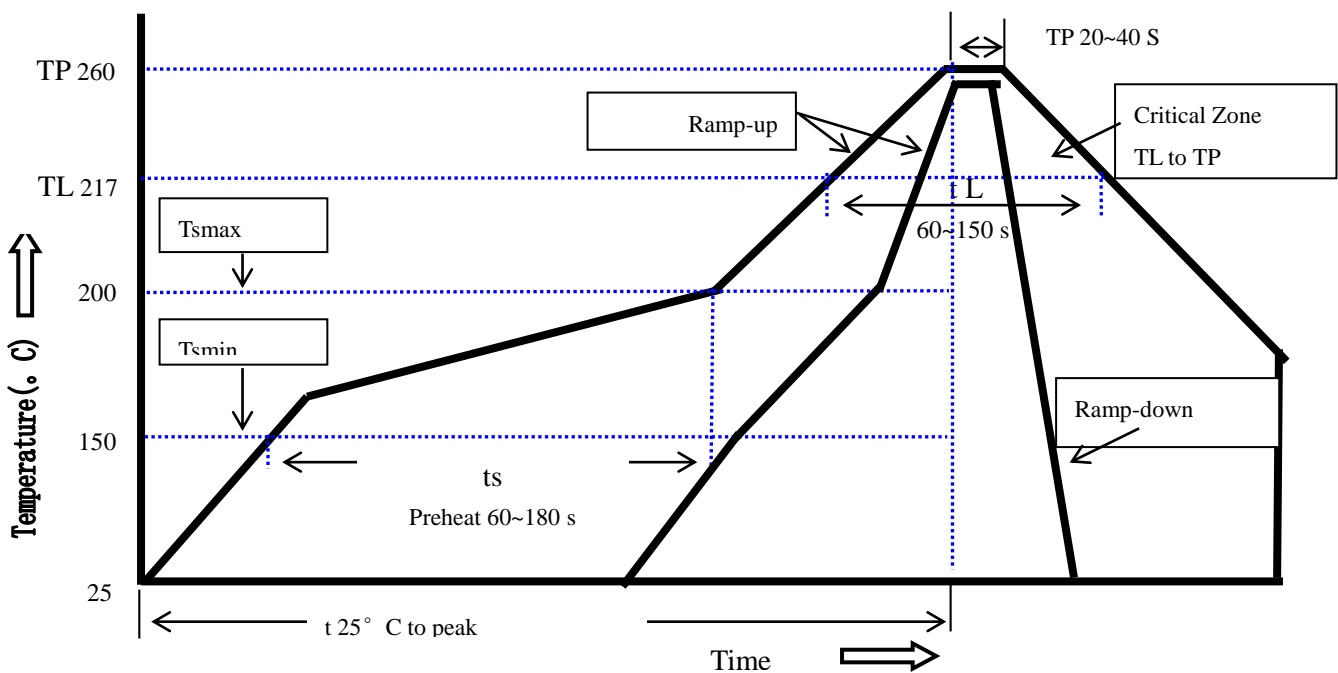
### Thermal Derating Curve



### Average Time-Current Curve



### Soldering Parameters



Profile Feature	Pb-Free Assembly
Average Ramp-Up Rate(Ts max to T p)	3°C/second mac.
Preheat	
-Temperature Min(Ts min)	150°C
-Temperature Max(Ts max)	200°C

Time(Ts min to Ts max)	60~180 seconds
Time maintained above:	
-Temperature(TL)	217°C
-Time(tL)	60~150 seconds
Peak Temperature(Tp)	260°C
Ramp-Down Rate	6°C/second max.
Time 25°C to Peak Temperature	8 minutes max
Storage Condition	0°C~35°C,30%-60%RH

Recommended reflow methods: IR, vapor phase oven, hot air oven, N2 environment for lead-free

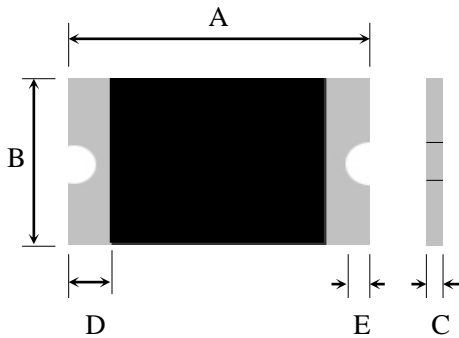
Recommended maximum paste thickness is 0.25mm

Devices can be cleaned using standard industry methods and solvents.

Note 1: All temperature refer to topside of the package, measured on the package body surface.

Note 2: If reflow temperatures exceed the recommended profile, devices may not meet the performance requirements.

## Physical Dimensions(mm.)



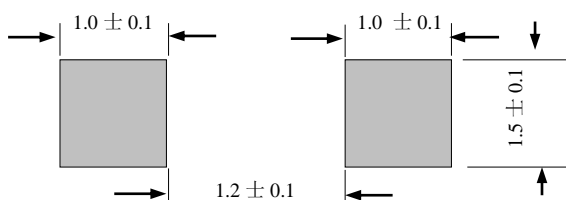
型號	A		B		C		D	E
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Min.
SMD0805P050TF/12	2.00	2.20	1.20	1.50	0.50	1.10	0.20	0.10

### Termination Pad Characteristics

Terminal pad materials: Tin-plated Nickel-Copper

Terminal pad solder ability: Meets EIA specification RS186-9E and ANSI/J-STD-002 Category 3.

## Recommended Pad Layout (mm)



## Packaging Quantity

Part Number	Quantity
SMD0805P050TF/12	4,000 pcs/reel

Tape & reel packaging per EIA481-1

## Tape And Reel Specifications (mm)

Governing Specifications		EIA 481-1
W		$8.0 \pm 0.3$
P0		$4.0 \pm 0.10$
P1		$4.0 \pm 0.10$
P2		$2.0 \pm 0.05$
A0		$1.45 \pm 0.10$
B0		$2.30 \pm 0.10$
B1max.		4.35
D0		$1.55 + 0.1, -0$
F		$3.5 \pm 0.05$
E1		$1.75 \pm 0.10$
E2min.		6.25
T		0.25
T1max.		0.1
K0		$0.74 \pm 0.1$
Leader min.		390
Trailer min.		160
Reel Dimensions		
A max.		178
N min.		60
W1		$9.0 \pm 0.5$
W2		$12.0 \pm 0.05$

